

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
OGAWA, KATSUHISA

Examiner

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Art Unit

2444

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,065,064 A	05-2000	Satoh et al.	709/249
*	B	US-2003/0026241 A1	02-2003	Ono et al.	370/349
*	C	US-2003/0037012 A1	02-2003	Mersky et al.	705/75
*	D	US-2003/0061380 A1	03-2003	Saito et al.	709/238
*	E	US-6,625,662 B1	09-2003	Satoh et al.	709/250
*	F	US-6,959,009 B2	10-2005	Asokan et al.	370/475
*	G	US-2006/0020525 A1	01-2006	Borelli et al.	705/034
*	H	US-2006/0056420 A1	03-2006	Okuda et al.	370/395.54
*	I	US-7,197,579 B2	03-2007	Saito et al.	710/15
*	J	US-7,272,140 B2	09-2007	Okamoto, Tsugio	370/392
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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